

# MOSFET - Power, Single N-Channel, TOLL 80 V, 0.79 mΩ, 457 A NTBLSOD8NO8X

### **Features**

- Low Q<sub>RR</sub>, Soft Recovery Body Diode
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# **Typical Applications**

- Synchronous Rectification (SR) in DC-DC and AC-DC
- Primary Switch in Isolated DC-DC Converter
- Motor Drives

# **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	$V_{DSS}$	80	V	
Gate-to-Source Voltage		$V_{GS}$	±20	V
Continuous Drain Current	T <sub>C</sub> = 25°C	I <sub>D</sub>	457	Α
	T <sub>C</sub> = 100°C		323	
Power Dissipation	T <sub>C</sub> = 25°C	$P_{D}$	325	W
Pulsed Drain Current	Ŭ ,		1629	Α
Pulsed Source Current (Body Diode)	t <sub>p</sub> = 100 μs	I <sub>SM</sub>	1629	
Operating Junction and Storage T Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Source Current (Body Diode)	I <sub>S</sub>	547	Α	
Single Pulse Avalanche Energy (I	E <sub>AS</sub>	530	mJ	
Lead Temperature for Soldering P (1/8" from case for 10 s)	TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

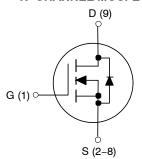
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Actual continuous current will be limited by thermal & electromechanical application board design.

1

3.  $E_{AS}$  of 530 mJ is based on started  $T_J$  = 25°C,  $I_{AS}$  = 103 A,  $V_{DD}$  = 64 V,  $V_{GS}$  = 10 V, 100% avalanche tested.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
80 V	0.79 m $\Omega$ @ 10 V	457 A	

# **N-CHANNEL MOSFET**





H-PSOF8L CASE 100CU

### **MARKING DIAGRAM**



A = Assembly Location

Y = Year WW = Work Week

ZZ = Assembly Lot Code 0D8N08 = Specific Device Code

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBLS0D8N08X	H-PSOF8L (Pb-Free)	2000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

**Table 1. THERMAL CHARACTERISTICS** 

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	0.46	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{ heta JA}$	43	

Table 2. ELECTRICAL CHARACTERISTICS $(T_J =$	25°C unless otherwise noted)
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Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}, T_J = 25^{\circ}\text{C}$	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\frac{\Delta V_{(BR)DSS}}{\Delta T_J}$	I <sub>D</sub> = 1 mA, Referenced to 25°C		35.5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 80 V, T <sub>J</sub> = 25°C		2		μΑ
		V <sub>DS</sub> = 80 V, T <sub>J</sub> = 125°C			250	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A, T <sub>J</sub> = 25°C		0.69	0.79	mΩ
		V <sub>GS</sub> = 6 V, I <sub>D</sub> = 71 A, T <sub>J</sub> = 25°C		1	1.26	1
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}, I_D = 720 \mu A, T_J = 25^{\circ}C$	2.4		3.6	٧
Gate Threshold Voltage Temperature Coefficient	$\Delta V_{GS(th)}/ \Delta T_J$	$V_{GS} = V_{DS}$ , $I_D = 720 \mu A$		-7.95		mV/°C
Forward Transconductance	9FS	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 80 A		485		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE					
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz		12920		pF
Output Capacitance	C <sub>oss</sub>			3670		
Reverse Transfer Capacitance	C <sub>rss</sub>			55		
Output Charge	Q <sub>oss</sub>	7		262		nC
Total Gate Charge	Q <sub>G(tot)</sub>	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 80 A, V <sub>GS</sub> = 6 V		109		
		$V_{DD} = 40 \text{ V}, I_D = 80 \text{ A}, V_{GS} = 10 \text{ V}$		174		
Threshold Gate Charge	Q <sub>G(th)</sub>	Ι Γ		34		
Gate-to-Source Charge	$Q_{gs}$			54		
Gate-to-Drain Charge	$Q_{\mathrm{gd}}$			32		
Gate Plateau Voltage	$V_{gp}$			4.6		V
Gate Resistance	$R_{g}$	f = 1 MHz		0.5		Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>d(on)</sub>	Resistive Load, V <sub>GS</sub> = 0/10 V,		34		ns
Rise Time	t <sub>r</sub>	$V_{DD} = 40 \text{ V}, I_{D} = 80 \text{ A}, R_{G} = 2.5 \Omega$		15		
Turn-Off Delay Time	t <sub>d(off)</sub>			70		7
Fall Time	t <sub>f</sub>			20		
SOURCE-TO-DRAIN DIODE CHARACTE	RISTICS					
Forward Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 80 A, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 25°C		0.8		V
		I <sub>S</sub> = 80 A, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125°C		0.66		
Reverse Recovery Time	t <sub>rr</sub>	$V_{GS} = 0 \text{ V, } I_{S} = 80 \text{ A}$		48		ns
Charge Time	ta	dl/dt = 1000 A/μs, V <sub>DD</sub> = 40 V		27		
Discharge Time	t <sub>b</sub>			49		
Reverse Recovery Charge	Q <sub>rr</sub>			464		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

# **TYPICAL CHARACTERISTICS**

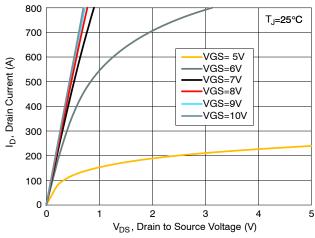


Figure 1. On-Region Characteristics

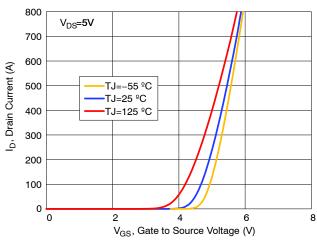


Figure 2. Transfer Characteristics

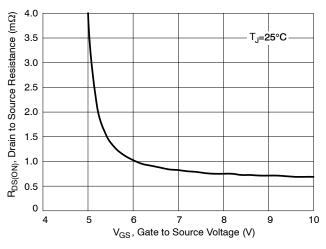


Figure 3. On-Resistance vs. Gate Voltage

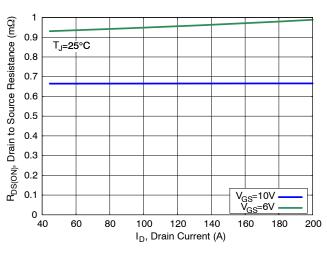


Figure 4. On-Resistance vs. Drain Current

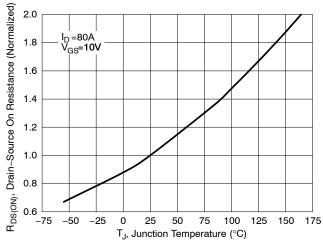


Figure 5. Normalized On-Resistance vs. **Junction Temperature** 

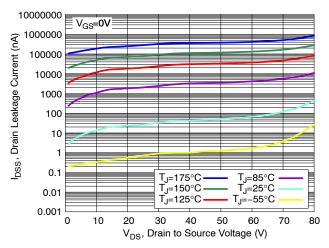


Figure 6. Drain Leakage Current vs. Drain Voltage

# **TYPICAL CHARACTERISTICS**

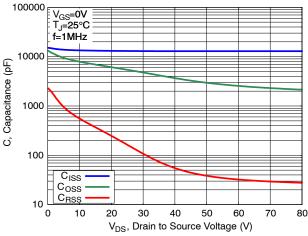


Figure 7. Capacitance Characteristics

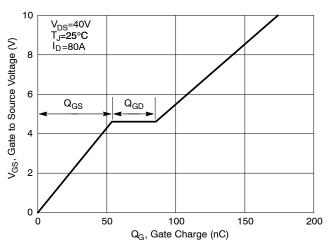


Figure 8. Gate Charge Characteristics

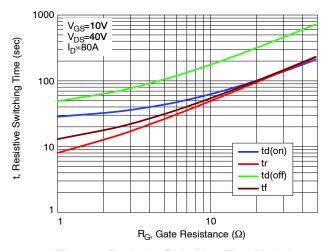


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

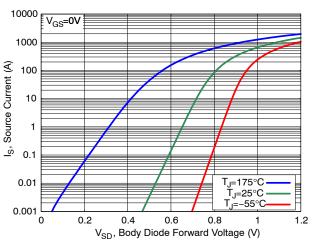


Figure 10. Diode Forward Characteristics

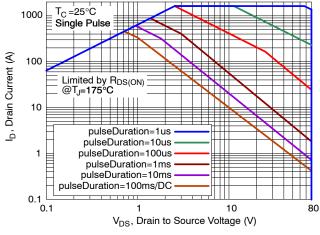


Figure 11. Safe Operating Area (SOA)

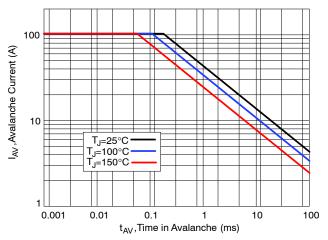


Figure 12. Avalanche Current vs. Pulse Time (UIS)

# **TYPICAL CHARACTERISTICS**

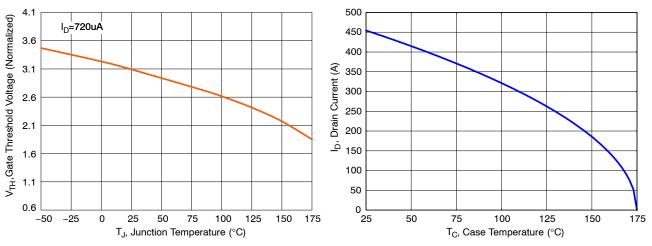


Figure 13. Gate Threshold Voltage vs. Junction Temperature

Figure 14. Maximum Current vs. Case Temperature

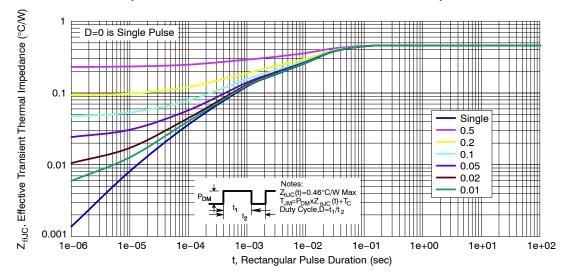
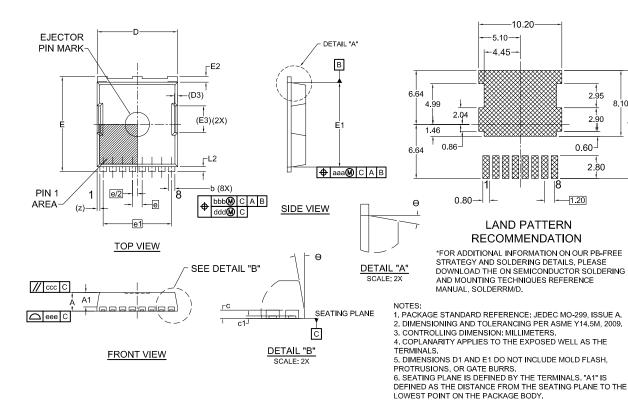
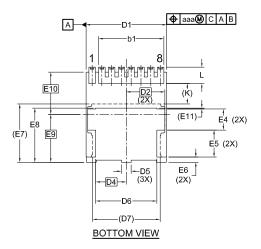


Figure 15. Transient Thermal Response

### **PACKAGE DIMENSIONS**

# H-PSOF8L 11.68x9.80 CASE 100CU **ISSUE B**





Diw	MIN.	NOM.	MAX.	
Α	2.20	2.30	2.40	
A1	1.70	1.80	1.90	
b	0.70	0.80	0.90	
b1	8.00 REF			
С	0.40	0.50	0.60	
c1	0.10			
D	9.70	9.80	9.90	
D1	9.80	9.90	10.00	
D2	4.73 BSC			
D3	0.40 REF			
D4	3.75 BSC			
D5		1.20		
D6	7.40	7.50	7.60	
_				

MILLIMETERS

D7	8.30 REF				
Е	11.58	11.68	11.78		
E1	10.28	10.38	10.48		
E2	0.60	0.70	0.80		
E3	;				
E4		2.60			
E5		3.30			
	E E1 E2 E3 E4	E 11.58 E1 10.28 E2 0.60 E3 :	E 11.58 11.68 E1 10.28 10.38 E2 0.60 0.70 E3 3.30 REF E4 2.60		

- '	3001.				
	DIM	MILLIMETERS			
	Diw	MIN.	NOM.	MAX.	
Ī	E6	_	0.65		
	E7	7.15 REF			
	E8	6.55	6.65	6.75	
	E9	5.89 BSC			
	E10		5.19 BSC		
	E11		0.10 REF	:	
	е	1.20 BSC			
	e/2	0.60 BSC			
	e1	8.40 BSC			
	K	2.43 2.53 2.63			
	L	1.90	2.00	2.10	
	L2	0.50	0.60	0.70	
	Z		0.35 REF	•	
	θ	0°		12°	
	aaa	0.20 0.25 0.20 0.20			
	bbb				
	ccc				
	ddd				
	eee	0.10			

8.10

13.28

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